

Search Notes

Application/Control No.

10/028,029

Examiner

Gopal C. Ray

Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

2111

SEARCHED

Class	Subclass	Date	Examiner
710	22,300,30 8,72,74,24 0,241,113	8/29/2005	GCR
711	100,202	8/29/2005	GCR
709	208,212	8/29/2005	GCR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
PGPUB text search - see interference search printout		8/29/2005	GCR

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST: USPT, US OCR, EPO ABS, JPO ABS, DWPI, IBM TDB (see search history printouts)	8/29/2005	GCR
EAST: USPT (see search history printouts)	8/29/2005	GCR
NPL: IEEE Xplore (see search history printouts)	8/29/2005	GCR